

11 PART OF PAPER #5

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 216630US2		SERIAL NO. 09/997,304	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Masahiro TAMURA, et al.			
				FILING DATE November 30, 2001		GROUP 3651	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER		NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
5	AO	10-310320	11/24/98	JAPAN (with English Abstract)			X
25	AP	10-245148	09/14/98	JAPAN (with English Abstract)			X
25	AQ	08-198505	08/06/96	JAPAN (with English Abstract)			X
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner D. K. Sear					Date Considered 2/4/04		

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

216630US2

SERIAL NO.

09/997,304

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Masahiro TAMURA, et al.

FILING DATE

November 30, 2001

GROUP

3651

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
ds	AO	198 44 232	03/30/2000	GERMANY (with English Abstract)		X
ds	AP	197 31 481	05/14/98	GERMANY (with English Abstract)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

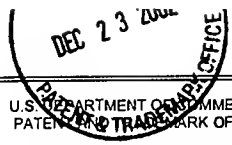
	AW	Patent Abstracts of Japan, JP 2001-348155, December 18, 2001
	AX	Patent Abstracts of Japan, JP 2000-219406, August 8, 2000
	AY	
	AZ	
Examiner <i>W. K. Seal</i>		<input type="checkbox"/> Additional References sheet(s) attached
		Date Considered <i>2/4/04</i>

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3651

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
25	AA	5,791,644	08/11/98	L. A. REGIMBAL, et al.			
	AB	5,762,328	06/09/98	K. YAMADA, et al.			
	AC	5,037,077	08/06/91	K. KUBOTA, et al.			
	AD	5,320,336	06/14/94	S. ASAMI			
	AE	5,931,460	08/03/99	H. KADOWAKI, et al.			
	AF						
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	AH						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	2000-143073	05/23/2000	JAPAN (with English Abstract)		X
	AP	6-43418	02/23/93	JAPAN (with English Abstract)		X
	AQ	2-269-582	02/16/94	GREAT BRITAIN		
	AR	6-100229	04/12/94	JAPAN (with English Abstract)		X
	AS	62-46862	02/28/87	JAPAN (with English Abstract)		X
	AT	2000-86064	03/28/2000	JAPAN (with English Abstract)		X
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

D. K. See

Date Considered

2/4/04

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